

<b>Notice of References Cited</b>	Application/Control No. 10/508,803	Applicant(s)/Patent Under Reexamination FUJIWARA ET AL.	
	Examiner FRANKLIN S. ANDRAMUNO	Art Unit 2424	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,751,613	06-2004	Lee et al.	707/5
*	B	US-6,581,207	06-2003	Sumita et al.	725/46
	C	US-			
	D	US-			
	E	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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	N					
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**NON-PATENT DOCUMENTS**

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